# A Single-Chip Bidirectional Neural Interface With High-Voltage Stimulation and Adaptive Artifact Cancellation in Standard CMOS

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bidirectional Abstract—A single-chip, brain-computer interface (BBCI) enables neuromodulation through simultaneous neural recording and stimulation. This article presents a prototype BBCI application-specified integrated circuit (ASIC) consisting of a 64-channel time-multiplexed recording frontend, an area-optimized four-channel high-voltage compliant stimulator, and electronics to support the concurrent multichannel stimulus artifact cancellation. Stimulator power generation is integrated on a chip, providing  $\pm 11$ -V compliance from low-voltage supplies with a resonant charge pump. Highfrequency (~3 GHz) self-resonant clocking is used to reduce the pumping capacitor area while suppressing the associated switching losses. A 32-tap least mean square (LMS)-based digital adaptive filter achieves 60-dB artifact suppression, enabling simultaneous neural stimulation and recording. The entire chip occupies 4 mm<sup>2</sup> in a 65-nm low power (LP) process and is powered by 2.5-/1.2-V supplies, dissipating 205  $\mu$ W in recording and 142  $\mu$ W in the stimulation and cancellation back-ends. The stimulation output drivers achieve 31% dc-dc efficiency at a maximum output power of 24 mW.

*Index Terms*—Artifact cancellation, brain–computer interfaces, electrical stimulation, neural recording, time-division multiplexing.

# I. INTRODUCTION

**R**EALIZATIONS of small-form factor, ultralow-power bidirectional brain-computer interfaces (BBCIs) will enable the treatment of chronic neurophysiological disorders and allow new modes to investigate brain function. Neural stimulators have been shown to effectively alleviate the symptoms of Parkinson's disease [1], epilepsy [2], depression [3],

Manuscript received December 2, 2019; revised March 3, 2020; accepted April 14, 2020. Date of publication May 15, 2020; date of current version June 29, 2020. This article was approved by Guest Editor Lucien J. Breems. This work was supported by Medtronic and the Center for Neurotechnology, under NSF Award Number EEC-1028725. (*Corresponding author: John P. Uehlin.*)

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Digital Object Identifier 10.1109/JSSC.2020.2991524

Fig. 1. Example of the integrated bidirectional neural interface.

and obsessive-compulsive disorder [4]. The development of closed-loop neural interfaces with simultaneous recording and stimulation capabilities will increase therapy effectiveness by adapting to real-time measurements of the modulated neural tissue without input from a practitioner [5]. In addition, a sufficiently complex closed-loop interface could be used to reanimate the damaged neural tissue or drive neuroprostheses with sensorimotor feedback [6]. In addition to clinical applications, simultaneous stimulation and sensing opens new research opportunities for neuroscientists, including the study of neural plasticity [7] and low-latency neural mapping [8].

In order to increase the efficacy and accessibility of potentially life-changing treatments, BBCI implants must be developed with minimal cost, size, and power use. A singlechip BBCI implementation minimizes the area and power consumption by reducing the number of interconnects. In addition, standard scaled-CMOS technology offers dense and power-efficient digital devices for complex BBCI therapy protocols. A single-chip CMOS BBCI front-end requires the integration of recording, stimulation, and power generation electronics on the same substrate along with a sophisticated digital back-end. Fig. 1 shows the components of a singlechip BBCI front-end. In addition, resilient operation in chronic implants requires the capability to continuously adapt to a slowly varying environment to maintain the desired stimulation and recording function.

Critical challenges remain before the vision of implantable single-chip BBCI neural interfaces becomes a reality; this article addresses two such challenges. First, the voltages generated at the stimulator–electrode interface (>10 V)

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regularly exceed the acceptable gate oxide breakdown limits (<1.5 V) for reliable operation in advanced, scaled CMOS technologies [9]. Second, the electrical stimulation creates in-band artifacts that are several orders of magnitude larger than the signals targeted by neural recording front-ends (~100 mV versus ~100  $\mu$ V) [10].

Recent implementations use a variety of techniques to address stimulation artifacts. One approach simply migrates to a high-voltage (HV) CMOS process, where the traditional current/voltage-driving structures can readily tolerate high stimulation voltages. The recording channels have been designed in HV processes that are naturally immune to large voltage swings due to stimulation artifacts [11]. However, the large core devices in these processes are less suited for efficient integration of digital processing algorithms as will be demanded of future generation BBCIs. Other implementations mitigate the stimulation artifacts by overdesigning the record front-end dynamic range. These approaches quantize both the large stimulus artifact and the underlying neural signals [12]-[16], relying on a DSP back-end to digitally remove the artifact. The front-end overdesign can create a recording non-linearity (voltagecontrolled oscillator (VCO)-based ADCs [12]) and introduces area, complexity, or power-consumption tradeoffs. Artifacts are most efficiently mitigated using the adaptive mixed-signal feedback in the front- and back-ends [17]-[19]. The proposed multiplexed canceller is optimized to reduce the power consumption, using less than 50 nW per artifact channel during continuous operation, and less than 8 nW per channel for a standard 10-Hz stimulation rate.

This article achieves HV stimulation compliance ( $\pm 11$  V) using stacked circuits in low-voltage scaled CMOS. The stacked driver architecture enables constant-current stimulation through a large range of electrode impedances from the same chip as a complex, efficient digital back-end. Charge pumps are typically used to create above- $V_{DD}$  stimulation voltages, and the pumping capacitors dominate the system area. This article minimizes the charge pump area using integrated inductors to reclaim power while operating at a high charge pump clock frequency to reduce the area overhead. The proposed stimulator implements the first GHz-clocked charge pump to achieve aggressive area reduction in neural stimulation, while relying on resonance to effectively mitigate the adverse efficiency impact from this miniaturization.

The HV stimulators are integrated with the time-division multiplexed recording architecture from [20] and [21]. The recording system uses closed-loop adaptive feedback for stimulus artifact cancellation on multiple channels. The canceller computation hardware is also time-multiplexed to reduce power and area consumption. The resulting monolithic 65-nm CMOS chip includes all the necessary components to allow simultaneous 64-channel recording and 4-channel stimulation for BBCI-clinical applications. This article is an elaboration of the work presented in [22].

This article is organized as follows. Section II discusses the overall system architecture. Section III elaborates on the resonant H-bridge stimulator and analysis of power generation and efficiency. Section IV briefly describes the integrated recording channels. Section V describes the design and optimization of the adaptive artifact canceller. Section VI provides the system and circuit implementation details, as well as benchtop and *in vivo* measurements. Concluding remarks are presented in Section VII.

# II. SYSTEM OVERVIEW

A block diagram of the full system implemented is shown in Fig. 2. Four integrated H-bridge stimulators are independently tunable with digitally programmable current waveforms. The resonant charge pumps generate up to 11 V to drive up to 2 mA of sink-regulated current through the electrode– tissue load. The shared IDAC is switched between the two sides of the H-bridge.

A time-multiplexed, delta-encoded recording front-end [20], [21] records 64 channels using a single recording chain. A multiplexer routes all channels to a shared input capacitive DAC (CDAC), front-end amplifier, and successive approximation register (SAR) ADC. A digital integration loop increments the CDAC at the recording amplifier input to subtract lowfrequency signal content. Such a delta-encoded loop creates a frequency-shaped dynamic range well suited for the colored spectral shape of neural signals [23]. The system targets 64-channel electrocorticography (ECoG) recordings at 2 kS/s.

The digital back-end implements an adaptive artifact cancellation filter. A simplified least mean square (LMS) algorithm processes the recording output and stimulator control signals into a time-domain reconstruction of unwanted stimulus artifacts. The artifact voltage is subtracted using the CDAC at the recording amplifier input. The canceller computation hardware associated with adapting the filter is time-multiplexed between channels, and the filter coefficients are stored using an on-chipdedicated SRAM.

# III. RESONANT CHARGE PUMP H-BRIDGE STIMULATOR

# A. HV Stimulation

Constant-current stimulation pulses create large voltages at the load interface due to high electrode impedances [24]. This article uses an H-bridge stimulator topology to double the voltage compliance range for a given maximum output voltage. The stimulator output is ground-referenced, and each differential side has a dedicated charge pump to supply positive voltage as needed to each side of the load. The charge pumps are dynamically enabled to generate only as much voltage as necessary to drive the current through the tissue–electrode load. Specifics of the constant-current voltage control loop can be found in [25]. Compared with a fixed-supply stimulator [11], [26]–[28], dynamic voltage supplies save energy when stimulating below the maximum output voltage [29].

#### B. Resonant Charge Pump Voltage Supplies

This article uses a modified version of the cross-coupled switched capacitor charge pump presented in [30], which is well suited for use in triple-well, deep sub-micrometer integrated CMOS processes. The charge pump draws current from an input voltage,  $V_{\rm IN}$ , and adds the voltage proportional to the number of cascaded stages, n, and the clock voltage



Fig. 2. Functional block diagram of the BBCI chip architecture.

swing,  $V_{\text{CLK}}$ , applied to the flying pump capacitors,  $C_{\text{FLY}}$  (Fig. 3). The output voltage,  $V_O$ , droops for given output current,  $I_O$ , in proportion to the clock-switching frequency,  $f_{\text{CLK}}$ , and the flying capacitor size at each stage. This gives the following output voltage characteristic:

$$V_O = V_{\rm IN} + n(V_{\rm CLK} - I_O / f_{\rm CLK} C_{\rm fly}).$$
(1)

The switched capacitor charge pumps are typically implemented with large switches and capacitors at low frequencies, mitigating frequency-dependent reactive losses. Milliampere-level stimulation current with clock frequencies in the tens of megahertz requires large capacitors ( $\sim 100 \text{ pF}$ ) in the charge pumps, thus, dominating the overall stimulator silicon area [31].

Existing stimulators often use large (~1  $\mu$ F) off-chip flying capacitors switched at low frequencies (~100 kHz) [32], taking up more area than the core stimulator IC. This article reduces the silicon footprint dedicated to charge-pump flying capacitors by increasing  $f_{\rm CLK}$  to maintain the output power levels with smaller capacitor sizes. Efficiencies afforded by resonance ensure that  $f_{\rm CLK}$  increase does not adversely impact switching losses. A significant reduction in chargepump capacitance allows for single-chip implementations that include multiple stimulation sites.

Resonant charge pumps have been previously implemented for neural stimulators, but without an increase in switching frequency and corresponding area savings. A large, singlecoil inductor created around the chip boundary resonates with a single charge pump, with the goal of using the 24-nH coil as a wireless energy-harvesting mechanism [29]. The charge pump and inductor occupy 3 mm  $\times$  3 mm of the silicon area while only providing enough power for 145  $\mu$ A of stimulation at  $\pm 3.3$  V.

This article integrates eight resonant charge pumps dedicated in pairs to realize four fully integrated stimulators on a single chip. Each stimulator runs from a 500-mV  $V_{DD}$  and is capable of independently delivering up to 2 mA of current, while ramping to a maximum driver voltage of 11 V. During normal operation, the *LC* tank forms a free-running oscillator, obviating the need for a phased-locked loop.

The capacitance associated with a 12-stage cascaded charge pump is placed in parallel with a single differential inductor to create a resonant oscillator, as shown in Fig. 3. Large, cross-coupled NMOS devices generate negative impedance, compensating for resistive losses in the *LC* tank to ensure oscillation. An inductor center tap set to  $V_{\text{DDRES}}$  results in a 2- $V_{\text{DDRES}}$  voltage swing at the charge pump clock input. This differential oscillator topology was originally proposed for microprocessor clock generation in [33]. Here, a similar clocking concept is used to drive a capacitive charge pump, as opposed to a clock distribution network.

Optimizing the charge pump in the context of an *LC* tank requires a steady-state model to estimate the tank quality factor and the resulting charge pump efficiency. Calculating the charge pump efficiency begins by finding the dc current necessary to generate enough negative impedance in the cross-coupled NMOS pair to sustain a free-running oscillator. Resonating parasitic capacitances with an inductor mitigates  $CV^2 f$  losses. As such, the dc bias current of the oscillator drivers and the resistive losses in the series charge pump stages dominate the stimulator power loss.

The steady-state model in Fig. 3(b) assumes that each intermediate node between charge pump stages is an ac ground. Two complimentary switches are "ON" at any given time in each stage, and this is represented as  $R_{SW}$ .  $C_{FLY}$  combines in series with the much smaller switch parasitics, so  $C_{FLY}$  is not included in this model. The remaining parasitic capacitances are represented by  $C_{PAR}$ , which contain the average of statedependent device parasitics (depletion region  $C_{gs}^{P,N, \text{off,on}}$ ) and state-independent capacitances ( $C_{gb}^{P,N}$ ,  $C_{ds}^{P,N}$ , and capacitor



Fig. 3. Transformation of (a) the resonant charge pump schematic into (b) an equivalent steady-state model and (c) equivalent half-circuit model for efficiency calculations.

bottom plate parasitics  $C_{\text{plate}}$ ). The total capacitance to ac ground, averaged between all clock states, is given by

$$C_{\text{PAR}} = 2C_{\text{plate}} + \frac{C_{\text{gs}}^{P,\text{off}} + C_{\text{gs}}^{N,\text{on}} + C_{\text{gs}}^{N,\text{off}} + C_{\text{gs}}^{P,\text{on}}}{2} + C_{\text{gb}}^{P} + C_{\text{gb}}^{N} + C_{\text{ds}}^{P} + C_{\text{ds}}^{N}.$$
 (2)

The capacitance between differential clock terminals,  $C_{SW}$ , is given by the gate–drain capacitance of the switches

$$C_{\rm SW} = 2C_{\rm gd}^P + 2C_{\rm gd}^N. \tag{3}$$

The cross-coupled NMOS devices also introduce their own parasitic resistance and capacitance, represented by  $r_{\rm ds}$ ,  $C_{\rm gs}$ , and  $C_{\rm gd}$ .

Transforming the series impedances in Fig. 3(b) into a set of parallel impedances yields a simplified expression to calculate the driver  $g_m$ . The inductor quality factor used to calculate an equivalent series resistance and transformed into a parallel resistance at the resonant frequency. With all the impedances in parallel form, the *LC* tank can be further simplified into a half-circuit, as shown in Fig. 3(c). The following equation results from this model and gives an estimate of the negative impedance necessary to sustain oscillation:

$$g_m > g_{\rm ds} + \frac{R_{\rm LS}(12(C_{\rm PAR} + 2C_{\rm SW}) + C_{\rm gs} + 4C_{\rm gd})}{L_S} + \frac{12}{R_{\rm SW}}.$$
 (4)

For a given inductance, the flying capacitor and switch sizes scale linearly with frequency for a set desired output current, given by the relationship

$$f = \frac{1}{2\pi \sqrt{L_s (12(C_{\text{PAR}} + 2C_{\text{SW}}) + C_{\text{gs}} + 4C_{\text{gd}})}}$$
$$= \frac{1}{2\pi \sqrt{L_s C_{\text{Total}}}}.$$
(5)

This allows the estimation of oscillator  $g_m$  in terms of operating frequency and inductor size. This expression includes the frequency-dependent quality factors from foundry-provided integrated inductors. In previous analysis, Q(f, L) was simplified as a series resistance,  $R_{LS}$ . The total parasitic capacitance,  $C_{Total}$ , is shortened to C for clarity. The switch parameters scale linearly with total capacitance, using simulation-verified values as the starting points ( $g_{ds0}$ ,  $R_{SW0}$ ,  $C_0$ )

$$g_{m}(f, L) = g_{ds} + \frac{R_{LS}C_{Total}}{L_{S}} + \frac{12}{R_{SW}} = g_{ds0}\frac{C(f)}{C_{0}} + \frac{1}{2\pi L_{S}f\left(Q(f, L) + \frac{1}{Q(f,L)}\right)} + \frac{12}{R_{SW0}}\frac{C_{0}}{C(f)} = \frac{g_{ds0}}{4\pi^{2}L_{S}f^{2}C_{0}} + \frac{Q(f, L)}{2\pi L_{S}f(Q(f, L)^{2} + 1)} + \frac{48\pi^{2}C_{0}L_{S}f^{2}}{R_{SW0}}.$$
(6)

The  $g_m$  necessary to sustain oscillation can be translated into a dc current drawn through the  $g_m/I_D$  ratio for a given operating regime and process technology. The oscillator startup begins in the subthreshold region, with  $g_m/I_D = 25$  in a 65-nm CMOS. Efficiency is calculated in terms of the ideal output power and the  $g_m$  given in (6). The following equation also includes losses in the frequency-dependent charge pump switch resistance,  $R_{SW}(f)$ :

$$\eta = \frac{P_{\text{OUT}}}{P_{\text{IN}}} = \frac{2 \text{ mA}(12 \text{ V} - 12 * 2 \text{ mA} * R_{\text{SW}}(f))}{25 * g_m(f, L) * 500 \text{ mV}}$$
$$= \frac{2 \text{ mA}(12 \text{ V} - 12 * 2 \text{ mA} * \frac{R_{\text{SW}0}}{4\pi^2 C_0 L_S f^2})}{25 * g_m(f, L) * 500 \text{ mV}}.$$
(7)

Fig. 4 graphically shows the resonant charge pump efficiency as a function of inductor size and self-oscillation



Fig. 4. Stimulator charge pump area and efficiency over frequency and inductor size. This analysis assumes a constant output current of 2 mA at 11 V from 12 cascaded stages, with the oscillator center tap drawing current from a 500-mV supply. Inductor quality factor, capacitor sizing, and switch optimization are based on process design kit (PDK) models and simulation.

frequency. The parallel combination of the charge pump and integrated inductor gives an efficiency peak in the low GHz.

Fig. 4 also includes an estimate of the overall area occupied by the resonant charge pump. This *LC* tank model assumes that the flying capacitors and integrated inductors dominate the overall area, and that the switches are sized to ensure the total parasitic capacitance is less than 10% of the flying capacitance. Maintaining this sizing limits the clock amplitude reduction arising from the series capacitive division.

The implemented resonant charge pump was designed at the minimum area point along the efficiency peak for various inductor sizes, as shown in Fig. 4. This optimum lies at a 3-GHz free-running frequency using a 180-pH integrated differential inductor. The 0.042-mm<sup>2</sup>charge pump area estimate matches the silicon area of the actual charge pump (including the inductor) in the fabricated device. The measured dc/dc converter efficiency of 31% matches the power efficiency predicted by the *LC* tank resonant charge pump model.

Compared to prior work with charge pumps clocked at 100 MHz [25], this architecture achieves similar losses in a  $6 \times$  small-form factor with a 3-GHz charge-pump clock frequency (31% versus 40% efficiency). Using larger, non-integrated inductors with a higher quality factor would enable higher efficiency with this topology, at the expense of a larger board-form factor.

#### C. H-Bridge Stimulator

The resonant charge pumps fit into the H-bridge stimulator architecture as shown in Figs. 5(b) and 6(a). The charge pump supplies power to one side of the H-bridge while the current is sink-regulated through the opposite side of the load. During the return phase, the opposite charge pump is enabled, and the current sinks through the previously active side. The H-bridgeswitching structure is formed with diodes and distributed current buffers to overcome the low 1.2-V voltage tolerance of individual CMOS devices. To avoid wasted energy, the charge pumps for a given supply side are only enabled when the shared supply comparator detects that the IDAC is going out of saturation. This regulates the stimulator output voltage to be no larger than necessary for the load current into the electrode impedance. The same supply comparator is reused for the two sides of the H-bridge. After stimulation on a given side, the track comparator on that side detects a forward/reverse bias in the diode through a capacitive divider. This comparator drives a discharge path in the charge pump until the diode is "OFF."

While one side of the H-bridge supplies voltage across the electrode–tissue interface, the current flows through a high-voltage adapter (HVA) into the current-controlling IDAC. A schematic of the HVA is shown in Fig. 5(c). The HVA is a multi-stage cascode operating as a current buffer, protecting the 1.2-V IDAC from large voltages as seen at the stimulator– electrode interface. When an H-bridge side is sourcing current, the charge pump output voltage is capacitively distributed across the cascode gates to ensure no transistor sees more than 1.2 V across its terminals. After stimulation, the floating nodes of the capacitive divider are discharged with accessory charge pumps (not shown). When sinking the current, the HVA gates are pre-charged to place the devices in triode and act as closed switches.

The sinking IDAC shown in Fig. 5(a) has 8 bits of resolution with a tunable least significant bit, nominally 10  $\mu$ A. An active cascode at the IDAC output provides a high output impedance of 600 M $\Omega$  (simulated).

The ground-referenced H-bridge requires discharge phases after each stimulation pulse. In addition, the stimulator operates on the condition that there are no other paths to ground connected to the tissue. Because the monopolar voltage supplies are used to double the headroom, a low-impedance ground path would cause the supply side of the H-bridge to source extra, non-regulated current. The implemented H-bridge provides a ground reference when not stimulated, removing the need for an additional reference.

#### IV. DIFFERENTIAL ARTIFACT CANCELLATION

#### A. Artifact Cancellation in the System

When delivering current into tissue, which is also connected to the recording electronics, the stimulation voltage propagates to the recording inputs and is measured as a so-called stimulus artifact. Artifacts at the recording channel input can be several orders of magnitude larger than the signals of interest in ECoG/neural applications and can be decomposed into differential-mode and common-mode components. We have observed differential artifacts as large as  $\pm 100$ -mV in vivo during HV stimulation with microwire recording and stimulation electrodes 1-mm apart. As shown in Fig. 7, the artifact canceller uses the recording system output to create a negative copy of differential artifacts. The canceller output sums with the input signal, eliminating the input artifact and revealing the underlying neural signal. Common-mode artifacts are mitigated with a switched-capacitor offset cancellation network, as described in [21].



Fig. 5. (a) H-bridge stimulator top-level block diagram, (b) detailed charge pump schematic, and (c) detailed HVA schematic.



Fig. 6. (a) H-bridge stimulator block diagram demonstrating the current flow during the active phase of a stimulation pulse. (b) H-bridge block diagram during the return phase. (c) Impedances in a realistic electrode-tissue load. (d) Resulting voltage profile for a constant-current pulse into a mixed resistor-capacitor load.



Fig. 7. Conceptual illustration of artifact cancellation at the recording front-end interface.

The time-multiplexed recording system uses a 10-bit CDAC at the input of the transconductance amplifier to delta-encode low-frequency signal content which relaxes the required dynamic range of a single recording channel ADC [20], [21]. Adaptive differential digital artifact cancellation is performed

through a separate feedback loop which utilizes the same CDAC at the recording channel input (Fig. 7). The recording architecture in this article is an enhancement of [20] and [21], with increased CDAC resolution and expanded digital tunability. This article focuses on a new implementation of



Fig. 8. Behavioral block diagram of a full LMS-based artifact canceller.

an on-chip differential cancellation technique, realized using an ensemble of adaptively trained impulse response filters for various stim/record channel pairs.

# B. FIR-Based Adaptive Filters

Fig. 8 shows an adaptive canceller algorithm where the finite impulse response (FIR) filter coefficients are adapted using an LMS algorithm. For an FIR-based canceller implementation, the filter input signal, x(n), is a time-domain representation of the stimulation current pulse. This input is convolved with a set of coefficients,  $\{c_0, c_N\}$  to create the filter output, y(n), to create the FIR filter transfer function

$$y(n) = \sum_{i=0}^{N} c_i x(n-i).$$
 (8)

The coefficients are trained based on the recording system output, e(n), which is the residual artifact and neural signal remaining after subtracting the FIR filter's output from the input signal, y'(n). The FIR coefficients can be trained with an LMS algorithm, where the update coefficient,  $\mu$ , tunes the step size at each update interval. Coefficients adapt the algorithm as

$$c_N(n+1) = c_N(n) + \mu e(n)x(n-N).$$
(9)

Implementing the full LMS/FIR adaptive filter shown in Fig. 8 requires power and area-intensive hardware. Each tap of the FIR filter requires two multipliers, one adder, and two delay cells. This cost is multiplied by the number of implemented filter channels. This article proposes a simplification of this adaptive filter that dramatically reduces the necessary hardware for similar functionality and performance across multiple channels.

# C. Impulse-Based Adaptive Filter

The end goal of the adaptive filter is a time-domain representation of the stimulation voltage artifact. The FIR coefficients in the previously described approach are an intermediate step, quantifying the channel which changes the stimulator output current into the voltage artifact at the recording channel input. This intermediate step can be removed by changing the filter input into a discrete delta function. The FIR coefficients can be trained to a time-domain representation of the artifact voltage waveform, with several added benefits: most multiplicands become unity, the updated hardware can be multiplexed, and the tapped delay line can be removed. With a discrete delta input signal propagating through the FIR filter, only one tap of the filter is active at a time. This removes the need for a sum at the filter output. In addition, the multiplication of each tap coefficient with the delayed filter input, x(n), is replaced with multiplication by zero or unity as the discrete impulse input propagates through the filter. For N samples after stimulation onset at  $n_0$ , the filter simplifies to

$$y(n) = \sum_{i=0}^{N} c_i \delta(n - n_0 - i) = c_{n - n_0}, \quad 0 \le n - n_0 \le N.$$
(10)

In this implementation, the same LMS update algorithm in (9) updates one coefficient at a time. Given the highspeed logic available in a scaled CMOS and the low sampling frequencies necessary for adequately representing neural signals, it is possible to time-domain multiplex one set of LMS update hardware between all the filter taps. Furthermore, the time-domain multiplexed recording architecture lends itself well to the multiplexing of filter hardware between multiple stimulation-recording channel pairs. A representation of this multiplexing is shown in Fig. 9. While the filter coefficients are adapting, the scaling of the error signal used in the LMS adaptation is simplified to a division via a bitwise shift. The update operation first rotates through the recording channels before progressing down the time-domain taps of the impulse response filter, as indicated by the helical spiral in Fig. 9. Somewhat noteworthy is the fact that although the adaptation hardware is being reused between different channels, the filter response for each stim-s' sense combination is adapted uniquely. Each artifact produced at one stimulation site propagates to each recoding site and has a unique artifact response and a dedicated set of coefficients. The distribution of the unique stored artifact values is shown in Fig. 10(b).

The filter can be further simplified to remove the tapped delay line. Only one tap is active at a time, so the only functionality required is the storage and recall of filter values. This article uses a writable lookup table to replace the FIR filter, removing the power-consuming delay line. An integrated SRAM stores the filter values. The artifact samples,  $y_{R,S}(n)$  in Fig. 10, are equivalent to the coefficients in (10),  $c_{n-n_0}$ . The artifact samples are indexed by the filter tap number, n, recording channel, R, and stimulation channel, S. The previously stored coefficient for a given index is read out of



Fig. 9. Demonstration of the artifact canceller multiplexing in the context of a full FIR-based adaptive filter.



Fig. 10. (a) Implemented SRAM lookup-based artifact canceller architecture. (b) Translation of SRAM values to multiple channels and time samples.



Fig. 11. System verification and measurement setup. Emulated electrode loads couple test signals to the on-chip recording inputs along with artifacts generated by the on-chip stimulator. The electrode model is altered to dc bias the recording input to ground; the 5-G $\Omega$  resistors are shunted to the ground rather than being parallel with the model capacitance.

the SRAM to an update operation block and written back for storage until the next sample.

The four stimulators operate independently, so that multiple artifacts can overlap on the same recording channel. In order to accommodate the overlapping artifacts, the canceller hardware is physically multiplexed for the four stimulators, while it is time-domain multiplexed across recording channels. This article implements four separate canceller back-ends, one for each stimulator, with each time-domain multiplexed between four recording channels. The CDAC sums all the four canceller outputs before subtracting them from the input. This operation assumes that overlapping artifacts linearly superimpose.

When processing recording data at 2 kS/s for 16 stim-sense pairs with 40 stimulation pulses per second, the canceller



Fig. 12. Measured output waveforms of all the four stimulators concurrently delivering peak currents of 2 mA with equal 5-k $\Omega$  resistive loads. Stimulator current waveforms programmed with the following shapes: 1) rising exponentials; 2) half-sines; 3) square waves; and 4) decaying exponentials.



Fig. 13. Measured stimulator output waveforms for a rectangular biphasic pulse into a resistive load. The  $10-\mu s$  pulses separated by  $5-\mu s$  supplying peak current of 2 mA into a  $5-k\Omega$  load impedance.

dissipates a total of 780 nW, or  $\sim$ 50 nW per channel. On the contrary, the full LMS method in [18], with multipliers for each filter tap, dissipates 910 nW per channel.



Fig. 14. Bench measurements of the closed-loop artifact canceller convergence with  $\pm 125$ -mV artifacts at 40 pulses/s coupled with a10- $\mu$ V, 50-Hz sine wave. (a) Convergence with a  $\pm 125$ -mV input-referred artifact within 120 stimulation pulses. (b) Details of the first 200 ms after reset. (c) Details of the last 200 ms after convergence. (d) PSD of recording output before cancellation and after cancellation.



Fig. 15. Bench measurements of canceller convergence with two concurrent and overlapping stimulation pulses. The first artifact, applied at t = 0, is identical to that shown in Fig. 13, with a  $\pm 125$ -mV input-referred artifact that is 8-ms wide. A second stimulator starts at t = 1 s at the same rate, 40 pulses/s, delayed by 4 ms so that the new  $\pm 75$ -mV artifacts overlap the initial  $\pm 125$ -mV artifacts by half of their duty cycle. (a) Transient domain plot showing convergence. (b) Artifact shapes measured separately and concurrently.

The adaptive artifact cancellation hardware readily scales with the number of recording channels by simply expanding the amount of SRAM integrated on a chip. This implementation includes reconfigurable on-chip memory for 16 possible stim-sense artifact combinations, each with 32 10-bit taps. The 5120-bit low-voltage custom SRAM occupies an area of 250  $\mu$ m × 300  $\mu$ m. The canceller can also interface with the off-chip memory through source-synchronous serialized communication.

The artifact cancellation depth is limited by the digital-toanalog interface. In this article, a 10-bit CDAC gives a possible 60 dB of cancellation with a  $\pm 125$ -mV full scale. Additional off-chip post-processing can achieve an increased cancellation depth above the 60 dB provided by this chip.

# V. MEASUREMENT RESULTS

The proposed system was fabricated in a TSMC 65-nm low power (LP) 1P9M CMOS and evaluated on both the bench and *in vivo*. These *in vivo* measurements were carried out on ketamine-sedated macaque monkeys with Utah (Blackrock Microsystems) or microwire electrode arrays chronically implanted in the motor cortex. Benchtop measurements involved emulating the electrode–tissue load using discrete resistors and capacitors. Resistive dividers translate the stimulator output voltage to a differential artifact voltage, coupled into the recording inputs with various test tones. The bench test configuration is shown in Fig. 11. The impedances were selected to replicate a microwire electrode array.

The resonant stimulation driver topology had a measured voltage compliance of  $\pm 11$ -V while driving up to 2 mA of output current. The stimulator charge pumps have a measured power efficiency of 31% while delivering maximum output current (2 mA, 11 V). A bench demonstration of the multichannel stimulation and the ability of this chip to deliver programmable current shapes are shown in Fig. 12. Details of a rectangular stimulation pulse into a resistive load are shown in Fig. 13. The 2-mA biphasic pulses are driven through a 5-k $\Omega$  load impedance with pulse widths of 10  $\mu$ s, separated by 5  $\mu$ s. The ripple from the comparator-based voltage regulation loop can be seen during the constant-current pulse.

Fig. 14 shows an example of the artifact filter convergence and cancellation of full-scale artifacts with bench recordings at 2 kS/s. A  $\pm$ 125-mV artifact was generated at 40 pulses/s using the on-chip stimulator driving an emulated electrode–tissue load (as shown in Fig. 11). This artifact was combined with a 10- $\mu$ V, 50-Hz test tone. Fig. 14(a) shows the full convergence progression. Fig. 14(b) shows the saturated artifact and the beginning of filter training during the first 200 ms after reset. Fig. 14(c) shows the recording and filter output after convergence. The power spectral density (PSD) plot in Fig. 14(d) shows signal integrity after artifact cancellation through the



Fig. 16. Measured *in vivo* LFP recordings (a) without stimulation-evoked potentials, (b) with stimulation-evoked potentials and artifacts, and (c) with stimulation-evoked potentials and cancelled artifacts.

preservation of the  $10-\mu$ V, 50-Hz test tone in the presence of full-scale artifacts.

Fig. 15 shows the convergence with artifacts from two independent stimulators on the same recording channel. Artifacts identical to those in Fig. 14 are applied at t = 0, and a second stimulator is activated at t = 1s. The second stimulator applies pulses to create  $\pm 75$ -mV artifacts at 40 pulses/s. This is the same rate as the first set of artifacts, and a 4-ms delay ensures that the artifacts overlap for 50% of their duration. The filter converges to an optimum solution after 5 s, as shown in Fig. 15(a). Details of the artifacts are shown in Fig. 15(b). This demonstrates the ability to simultaneously cancel artifacts from multiple stimulators with the on-chip cancellers.

The measurement shown in Fig. 16 illustrates artifact suppression *in vivo*. The recordings are shown of local field potentials (LFPs) in the motor cortex of a sedated non-human primate with a bandwidth of 10 Hz–1 kHz. The recordings are shown without stimulation, during stimulation without artifact suppression, and during stimulation with artifact suppression. Biphasic, differential stimulation of  $\pm 150 \ \mu$ A at five pulses per second was applied to differential electrodes 2 mm away from the differential recording electrodes on the same array. The  $\pm 50$ -mV differential artifacts were observed at the recording channel input via the oscilloscope, which the canceller suppresses to within ~100  $\mu$ V at the recording amplifier's input. Note that the artifacts in Fig. 16(b) are subject to the recording front-end saturation, reducing the post-recording amplitude to ~  $\pm 2$  mV.

In an *in vivo* recording environment, the canceller distinguishes between neural signals and artifacts by only locking on to signals correlated with the periodicity of stimulation and limiting the length of its adaptive response. Uncorrelated neural activity appears as random noise to the LMS algorithm



Fig. 17. (a) Measured benchtop transient recordings demonstrating artifact cancellation at 16 kS/s. Signals recorded before stimulation, during stimulation without cancellation, and post-cancellation with and without post-processing. (b) PSD profiles for 16-kS/s neural spike recordings in (a).



Fig. 18. Measured stimulator power efficiency for a range of dc output currents.

over many samples. Neural responses to stimulation are correlated, and cancellation of these signals is avoided by limiting the length of the adaptive filter in time to cover only the stimulus artifact.

Fig. 17 shows the bench testing of artifact cancellation while recording at 16 kS/s. Synthesized neural "spikes" are coupled into the recording input with voltage artifacts generated from an on-chip stimulator. The control signal is a series of  $50-\mu V$ neural spikes at 100 spikes/saec from a Coulburn Bio-Signal Calibrator. The stimulation artifacts are  $\pm 125$  mV in amplitude at 77 pulses/s, avoiding co-periodicity. Fig. 17(a) shows the recording measurements under the following conditions: 1) transient signal recording without stimulation; 2) with stimulation and artifact cancellation disabled; and 3) artifact cancellation hardware enabled and post-processing for further cancellation. The residual signal after post-processing is noncorrelated stimulator noise. Fig. 17(b) shows the corresponding

[27]	[11]	[28]	[18]	[19]	[26]	
TBioCAS '17	<b>VLSI '17</b>	<b>JSSC '17</b>	SSCL '18	<b>JSSC '18</b>	ISSCC '19	THIS WORK
111/100	HV180nm	130nm	65nm	65nm	130nm	65nm
HV180nm		3.3V	1V	0.8V	3.3V	1.2/2.5V
None	Fast Recovery	None	$77 dB^{\dagger}$	$92dB^{\dagger}$	Fast Recovery	60dB
18	0.7	1.07	-	-	-	0.62
25	11.52	4.98	5.14	1	11	4
16 SENSE	64 SENSE	64 SENSE	64 SENSE	16 SENSE	64 SENSE	64 SENSE
40 STIM	4 STIM	64 STIM	2 STIM		64 STIM	4 STIM
	±12V	3.1V	-	-	High-Freq	±11V
$\pm 12V$					E-Field	
From Supply	From Supply	From Supply	-	-	From Supply	31%
-	-	w/ Sense	-	-	w/ Sense	0.36mm <sup>2</sup>
Pulse	Arbitrary	Arbitrary	-	-	Arbitrary	Arbitrary
-	-	0.013	0.18	0.024	0.018	0.0025
5.4	8	0.63	2.7	0.8	0.79	3.21
7.68	1.6	1.13	8.2	0.73	2.1	2.9‡
<b>5</b> 1 11	kHz 500Hz	500Hz	8.3kHz	5kHz	500Hz	Tunable
7KHZ						<32kHz
-	100mV <sub>pp</sub>	13mV <sub>pp</sub>	200mV <sub>pp</sub>	260mV <sub>pp</sub>	Rail-Rail	110mV <sub>pp</sub>
10b Pipeline	ΔΣ OSR 1024	$\Lambda^2 \Sigma$	10b Nyquist	$\Lambda^2 \Sigma$	$\Lambda^2 \Sigma$	
		OSR 100		OSR 32	OSR 10k ENOB 10	Nyquist Δ- Encode ENOB 14
		ENOB 11.7		ENOB 10.7		
	[27] TBioCAS •17 HV180nm None 18 25 16 SENSE 40 STIM ±12V From Supply - - - - - - - - - - - - - - - - - - -	[27]         [11]           TBioCAS '17         VLSI '17           HV180nm         HV180nm           None         Fast Recovery           18         0.7           25         11.52           16 SENSE         64 SENSE           40 STIM         4 STIM           ±12V         ±12V           From Supply         From Supply           -         -           9ulse         Arbitrary           -         -           5.4         8           7.68         1.6           7kHz         500Hz           -         100mV <sub>pp</sub> 10b Pipeline         ΔΣ OSR 1024	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $

TABLE I Comparison With the State–of-the-Art Solutions

▼Includes stimulation power ▲ Reported area includes Wireless Power/TX or DSP † AFE dynamic range ‡ Calculated over 1-1kHz BW



Fig. 19. Micrograph of the fabricated 65-nm test chip.

PSD of each signal, demonstrating 60 dB of voltage cancellation on the artifact fundamental at 77 Hz and corresponding harmonics. Note that back-end post-processing provides an additional cancellation of 30 dB.

Apart from the stimulator output stages, the test chip consumes 620  $\mu$ W while operating a 64-channel recording at 2 kS/s, multiplexed artifact cancellation, and four stimulator back-ends. The 64-channel multiplexed recording system dissipates 205  $\mu$ W, the canceller consumes less than 1  $\mu$ W, and each of the stimulators uses 104  $\mu$ W when running with zero stimulation current. Stimulator output power is generated as needed by the on-chip resonant supplies, with the measured power efficiency shown in Fig. 18. A die photo of the fabricated 65-nm LP test chip is shown in Fig. 19 with a chip area of 4 mm<sup>2</sup>.

#### VI. CONCLUSION

A complete BBCI system with simultaneous recording and stimulation capabilities has been optimized for area efficiency and scalability in advanced CMOS technology (65-nm LP). The demonstrated chip integrates the HV stimulation on the same substrate as a LP recording front-end and digital computation. This scalable chip architecture enables uncorrupted neural recording on many channels during the full-amplitude stimulation.

A comparison with the state-of-the-art solutions is shown in Table I. This article condenses the stimulation power generation into a minimal silicon area, when compared to other works which require external HV supplies or charge pumps. The HV stimulation power train is integrated on the same standard CMOS substrate as a high-efficiency digital backend utilized for closed-loop artifact cancellation, opening the way for multi-application single-chip BBCIs.

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